Sear	ch	N	ot	es
------	----	---	----	----



K

Application/Control No.	Applicant(s)/Patent under Reexamination
10/801,106	SCHMIDT ET AL.
Examiner	Art Unit
Gerald Gauthier	2645

	SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		
•			
•			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		
L			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	1/27/2006	GG
379/88.13, 88.14 (keyword search)	1/27/2006	GG
		<u>.</u> .